

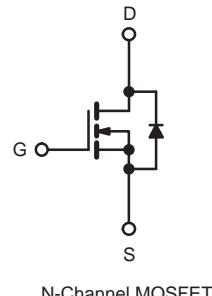
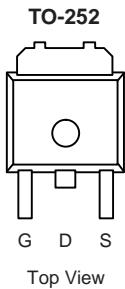
# 5R500CE-VB Datasheet

## N-Channel 500V (D-S) Super Junction Power MOSFET

<b>PRODUCT SUMMARY</b>	
V <sub>DS</sub> (V)	500
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V      0.55
Q <sub>g</sub> (Max.) (nC)	52
Q <sub>gs</sub> (nC)	13
Q <sub>gd</sub> (nC)	18
Configuration	Single

### FEATURES

- Low Gate Charge Q<sub>g</sub> Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective C<sub>oss</sub> Specified
- Compliant to RoHS directive 2002/95/EC


**RoHS\***  
 COMPLIANT


### APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply

<b>ABSOLUTE MAXIMUM RATINGS</b> T <sub>C</sub> = 25 °C, unless otherwise noted				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V <sub>DS</sub>	500	V
Gate-Source Voltage		V <sub>GS</sub>	± 30	
Continuous Drain Current	V <sub>GS</sub> at 10 V	I <sub>D</sub>	7	A
Continuous Drain Current			4.2	
Pulsed Drain Current <sup>a, e</sup>		I <sub>DM</sub>	44	
Linear Derating Factor			0.48	W/°C
Single Pulse Avalanche Energy <sup>b, e</sup>		E <sub>AS</sub>	275	mJ
Repetitive Avalanche Current <sup>a, e</sup>		I <sub>AR</sub>	11	A
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	6.0	mJ
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	60	W
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	6.9	V/ns
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	
Mounting Torque	6-32 or M3 screw		10	lbf · in
			1.1	N · m

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Starting T<sub>J</sub> = 25 °C, L = 4.5 mH, R<sub>G</sub> = 25 Ω, I<sub>AS</sub> = 11 A (see fig. 12).
- I<sub>SD</sub> ≤ 11 A, dI/dt ≤ 140 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C.
- 1.6 mm from case.
- Drain current limited by maximum junction temperature.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

**THERMAL RESISTANCE RATINGS**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	65	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	2.1	

**SPECIFICATIONS** T<sub>J</sub> = 25 °C, unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	610	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 30 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	-	25	μA
		V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.0 A <sup>b</sup>	-	0.55	-	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 6.6 A		6.1	-	-	S
<b>Dynamic</b>							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		-	1423	-	pF
Output Capacitance	C <sub>oss</sub>			-	208	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	8.1	-	
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 1.0 V, f = 1.0 MHz	-	2000	-	pF
			V <sub>DS</sub> = 400 V, f = 1.0 MHz	-	55	-	
			V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>	-	97	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 11 A, V <sub>DS</sub> = 400 V see fig. 6 and 13 <sup>b</sup>	-	-	52	nC
Gate-Source Charge	Q <sub>gs</sub>			-	-	13	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	18	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 11 A R <sub>G</sub> = 9.1 Ω, R <sub>D</sub> = 22 Ω, see fig. 10 <sup>b</sup>		-	14	-	ns
Rise Time	t <sub>r</sub>			-	35	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	32	-	
Fall Time	t <sub>f</sub>			-	28	-	
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	7.0	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	44	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 11 A, dI/dt = 100 A/μs <sup>b</sup>		-	510	770	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.4	5.1	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.  
c. C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 % to 80 % V<sub>DS</sub>.

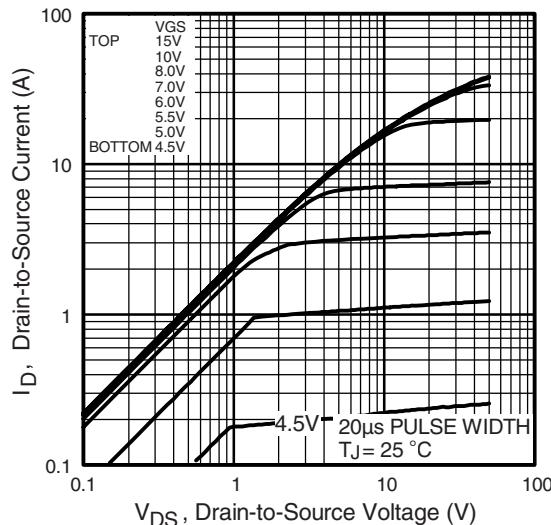
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

Fig. 1 - Typical Output Characteristics

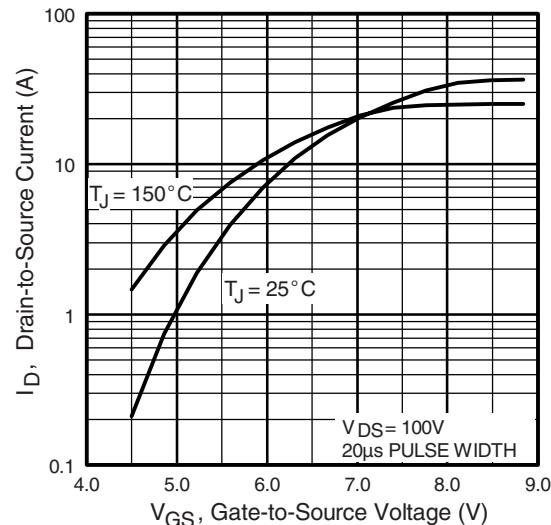


Fig. 3 - Typical Transfer Characteristics

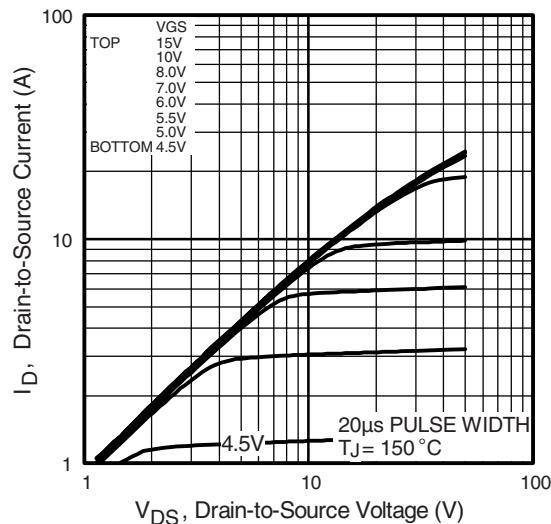


Fig. 2 - Typical Output Characteristics

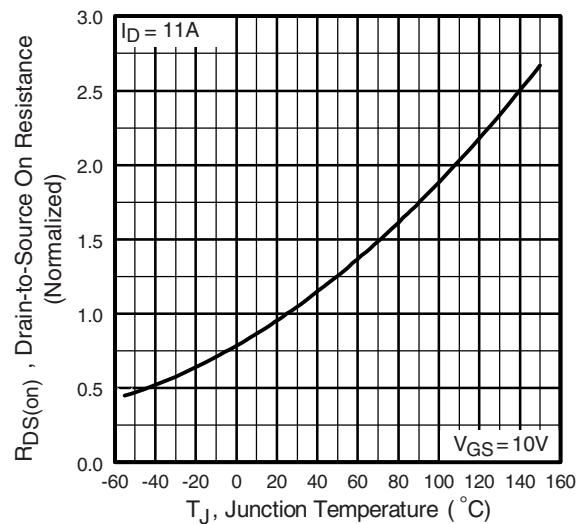


Fig. 4 - Normalized On-Resistance vs. Temperature

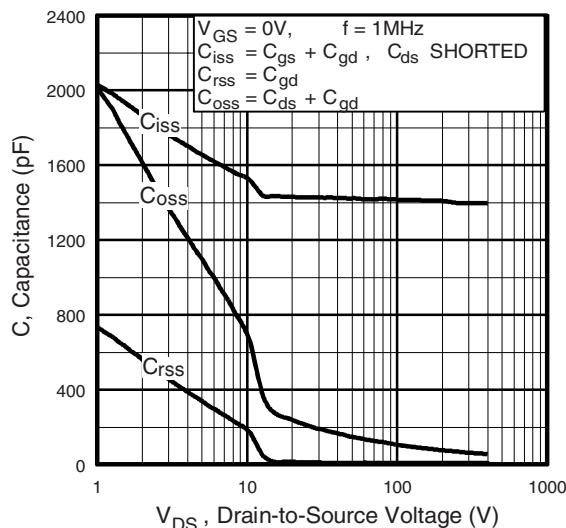


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

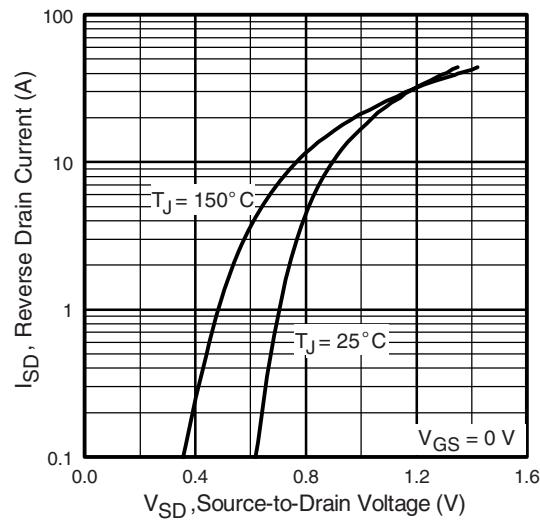


Fig. 7 - Typical Source-Drain Diode Forward Voltage

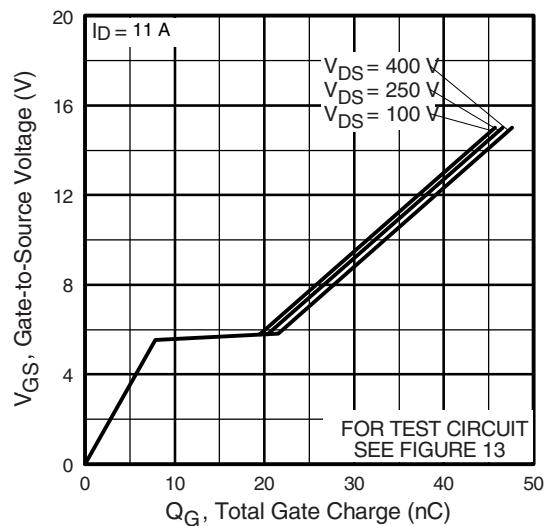


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

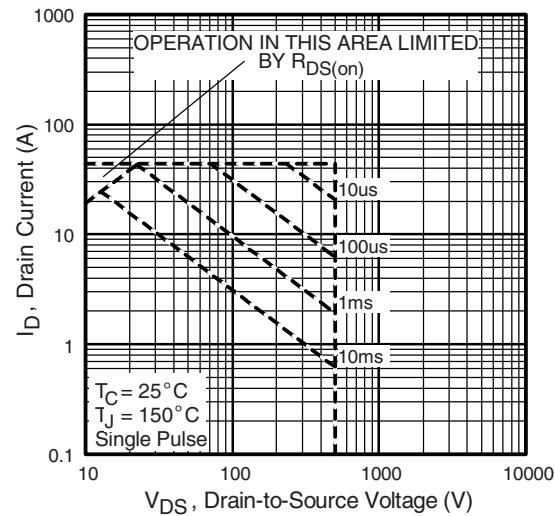


Fig. 8 - Maximum Safe Operating Area

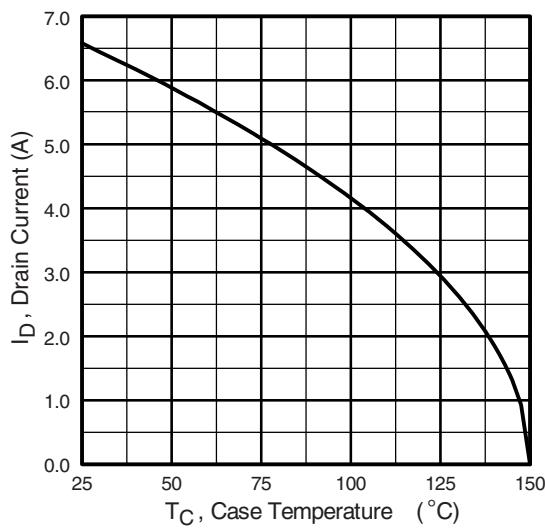


Fig. 9 - Maximum Drain Current vs. Case Temperature

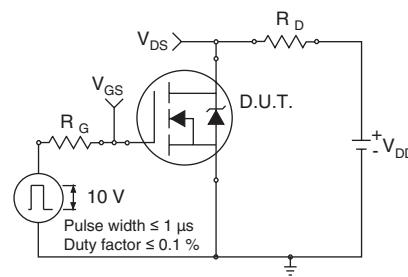


Fig. 10a - Switching Time Test Circuit

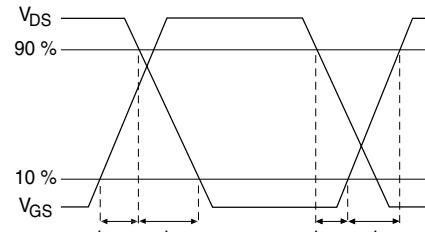


Fig. 10b - Switching Time Waveforms

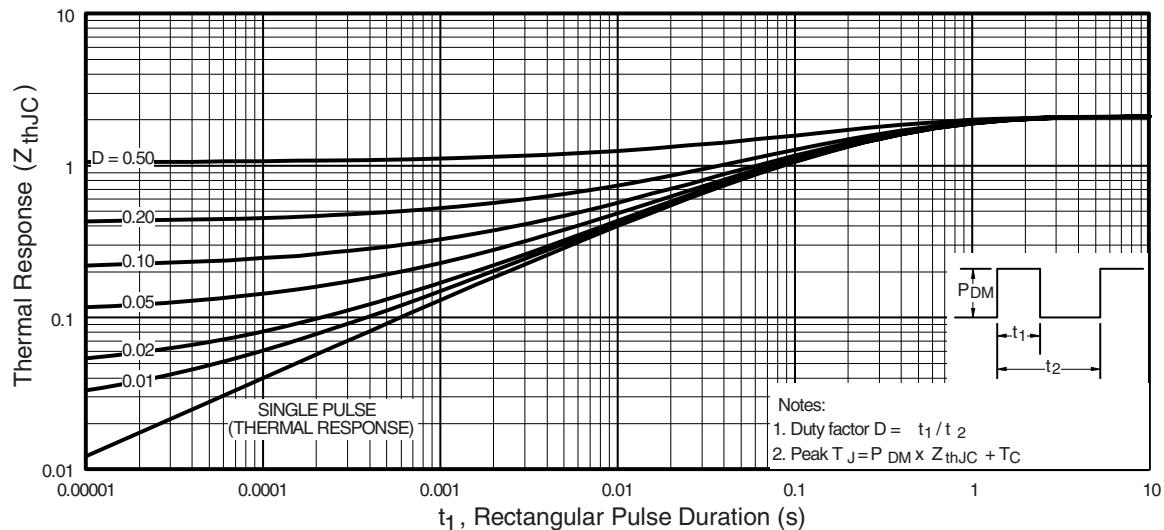


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

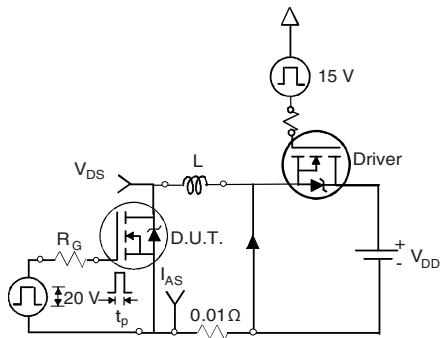


Fig. 12a - Unclamped Inductive Test Circuit

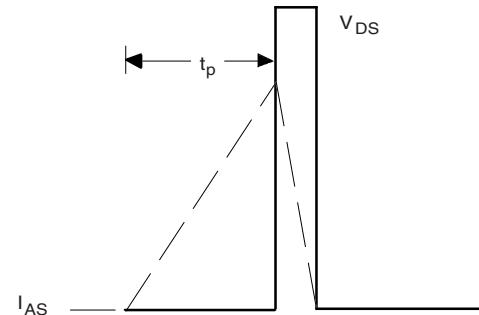


Fig. 12b - Unclamped Inductive Waveforms

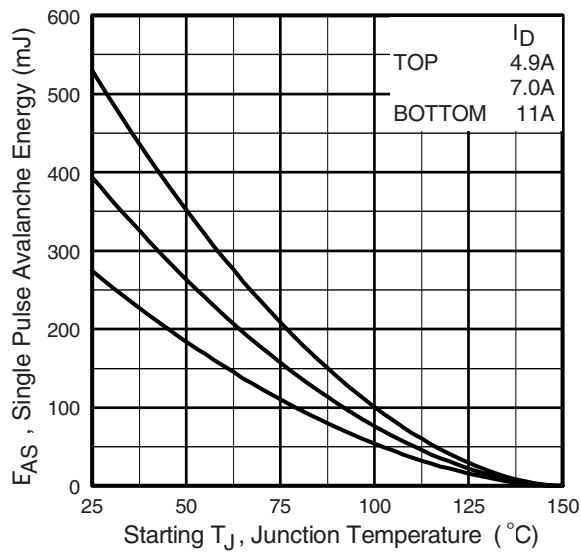


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

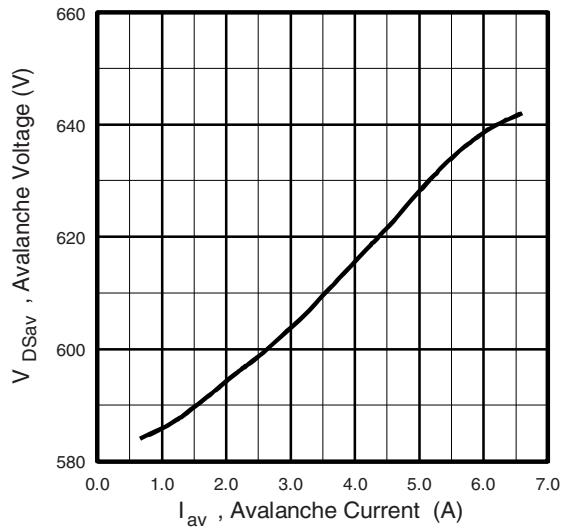


Fig. 12d - Typical Drain-to-Source Voltage vs. Avalanche Current

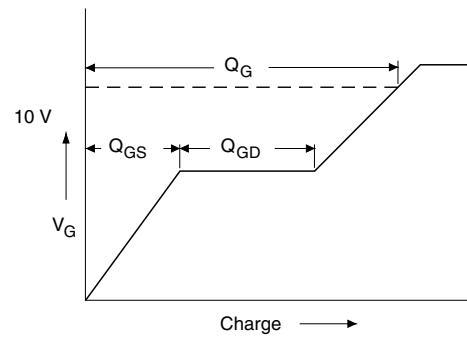


Fig. 13a - Basic Gate Charge Waveform

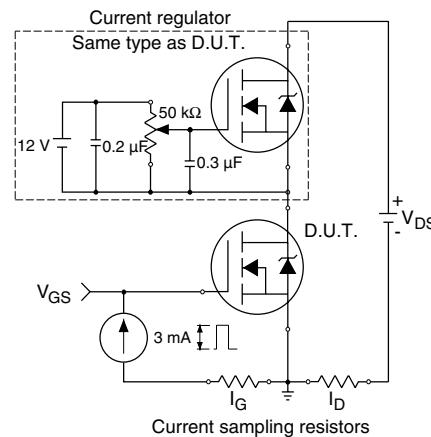
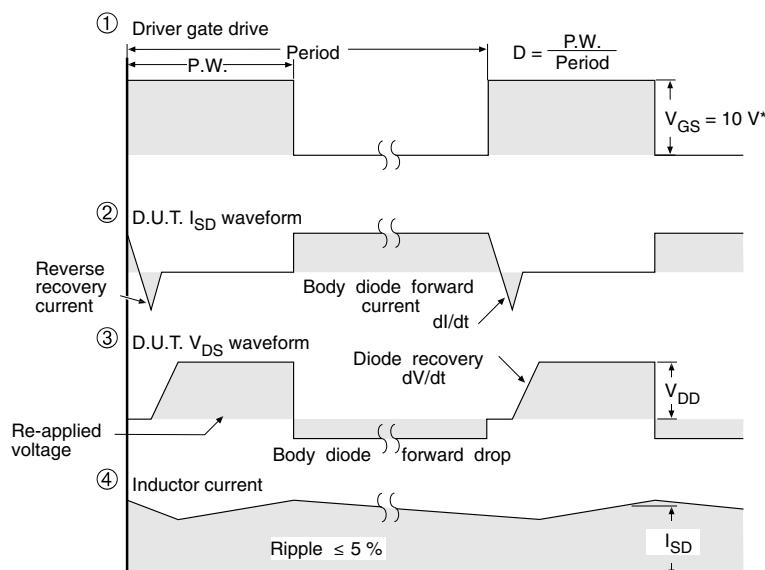
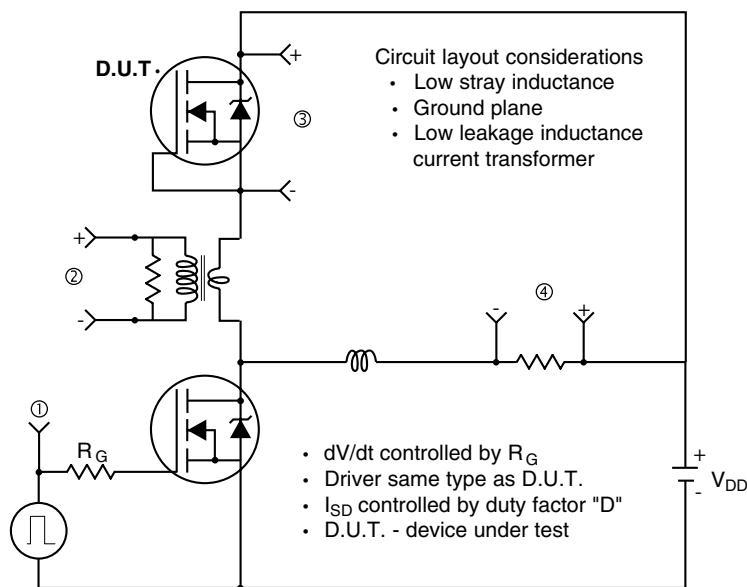


Fig. 13b - Gate Charge Test Circuit

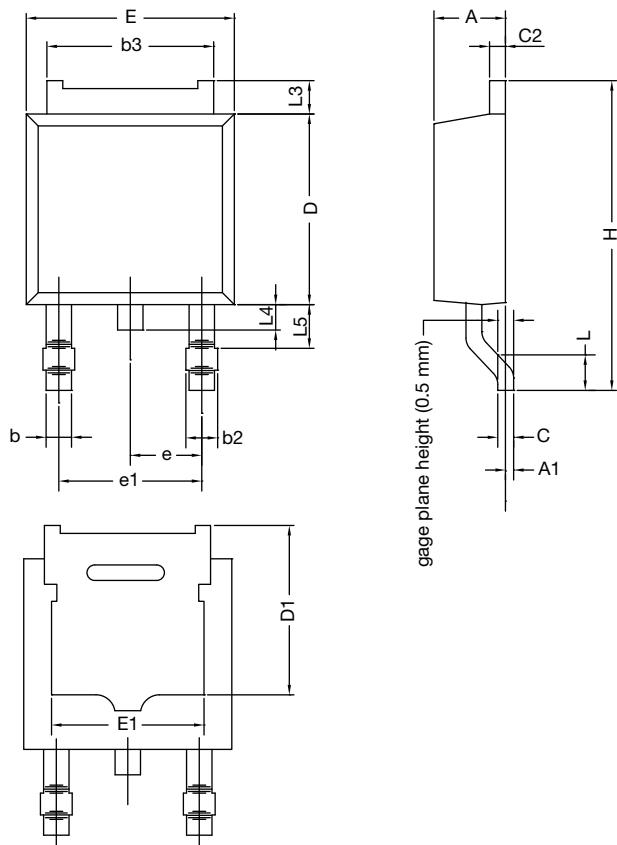
### Peak Diode Recovery dV/dt Test Circuit



\*  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel

## TO-252AA CASE OUTLINE



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.38	0.086	0.094
A1	-	0.127	-	0.005
b	0.64	0.88	0.025	0.035
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
C	0.46	0.61	0.018	0.024
C2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.21	-	0.205	-
E	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
H	9.40	10.41	0.370	0.410
e	2.28 BSC		0.090 BSC	
e1	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070
L3	0.89	1.27	0.035	0.050
L4	-	1.02	-	0.040
L5	1.14	1.52	0.045	0.060

ECN: X12-0247-Rev. M, 24-Dec-12  
DWG: 5347

**Note**

- Dimension L3 is for reference only.

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